



YEA SHIN TECHNOLOGY CO., LTD

YS9904M

Dual N-Channel Enhancement MOSFET



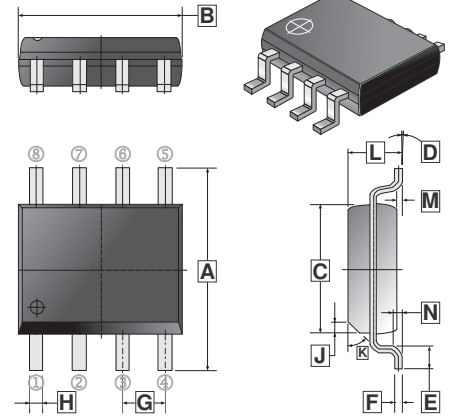
VDS= 40V, ID= 6.2A

SOP-8

DESCRIPTION

The YS9904M is the highest performance trench dual N-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

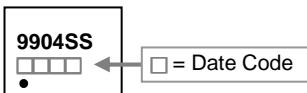
The YS9904M meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.



FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- 100% EAS Guaranteed
- Green Device Available

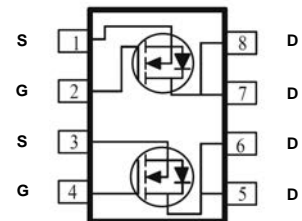
MARKING CODE



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.79	6.20	H	0.33	0.51
B	4.70	5.11	J	0.375 REF.	
C	3.70	4.10	K	45° REF.	
D	0°	8°	L	1.30	1.752
E	0.38	1.27	M	0.10	0.25
F	0.10	0.26	N	0.25 REF.	
G	1.27 TYP.				

PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	2.5K	13' inch



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V _{DS}	40	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current @ V _{GS} = 10V ¹	I _D	T _C = 25°C	7.2
		T _C = 100°C	5.6
Pulsed Drain Current ³	I _{DM}	14.5	A
Single Pulse Avalanche Energy ⁵	EAS	28	mJ
Avalanche Current	I _{AS}	7.5	A
Power Dissipation @ T _C = 25°C	P _D	2.5	W
Operating Junction & Storage Temperature Range	T _J , T _{STG}	-55~150	°C
Thermal Resistance Ratings			
Thermal Resistance Junction-ambient ¹	R _{θJA}	85	°C / W
Thermal Resistance Junction-ambient ²		135	
Thermal Resistance Junction-Case ¹	R _{θJC}	50	

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ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test condition
Static						
Drain-Source Breakdown Voltage	BV _{DSS}	40	-	-	V	V _{GS} =0V, I _D =250μA
Breakdown Voltage Temp. Coefficient	ΔBV _{DS} /ΔT _J	-	0.034	-	V / °C	Reference to 25°C, I _D =1mA
Gate-Threshold Voltage	V _{GS(th)}	1	-	2.5	V	V _{DS} =V _{GS} , I _D =250μA
Forward Transfer conductance	g _{fs}	-	14	-	S	V _{DS} =5V, I _D =6A
Gate-Body Leakage	I _{GSS}	-	-	±100	nA	V _{GS} =±20V
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1	μA	V _{DS} =32V, V _{GS} =0, T _J =25°C
		-	-	5		V _{DS} =32V, V _{GS} =0, T _J =55°C
Drain-Source On-Resistance ⁴	R _{DS(ON)}	-	-	30	mΩ	V _{GS} =10V, I _D =6A
		-	-	40		V _{GS} =4.5V, I _D =4A
Total Gate Charge	Q _g	-	5.5	-	nC	I _D =6A V _{DS} =20V V _{GS} =4.5V
Gate-Source Charge	Q _{gs}	-	1.25	-		
Gate-Drain ("Miller") Charge	Q _{gd}	-	2.5	-		
Turn-On Delay Time	T _{d(on)}	-	8.9	-	nS	V _{DS} =20V I _D =1A V _{GS} =10V R _G =3.3Ω R _D =20Ω
Rise Time	T _r	-	2.2	-		
Turn-Off Delay Time	T _{d(off)}	-	41	-		
Fall Time	T _f	-	2.7	-		
Input Capacitance	C _{iss}	-	593	-	pF	V _{GS} =0V V _{DS} =15V f=1.0MHz
Output Capacitance	C _{oss}	-	76	-		
Reverse Transfer Capacitance	C _{rss}	-	56	-		
Guaranteed Avalanche Characteristics						
Single Pulse Avalanche Energy ⁶	EAS	8	-	-	mJ	V _{DD} =25V, L=1mH, I _{AS} =4A
Source-Drain Diode						
Forward On Voltage ⁴	V _{DS}	-	-	1.2	V	I _S =1A, V _{GS} =0V
Continuous Source Current ¹	I _S	-	7.2	-	A	
Pulsed Source Current ³	I _{SM}	-	14.5	-	A	

Notes:

1. Surface mounted on a 1 inch² FR-4 board with 20Z copper.
2. When mounted on Min. copper pad.
3. The power dissipation is limited by 150°C junction temperature
4. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
5. The EAS data shows Max. rating . The test condition is V_{DD}=25V, V_{GS}=10V, L=1mH, I_{AS}=7.5A
6. The Min. value is 100% EAS tested guarantee.

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CHARACTERISTICS CURVE

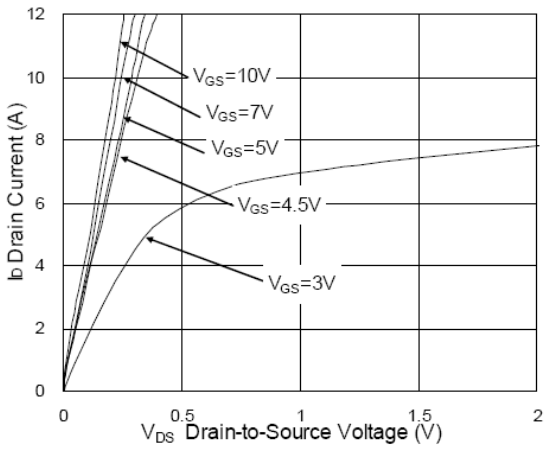


Fig.1 Typical Output Characteristics

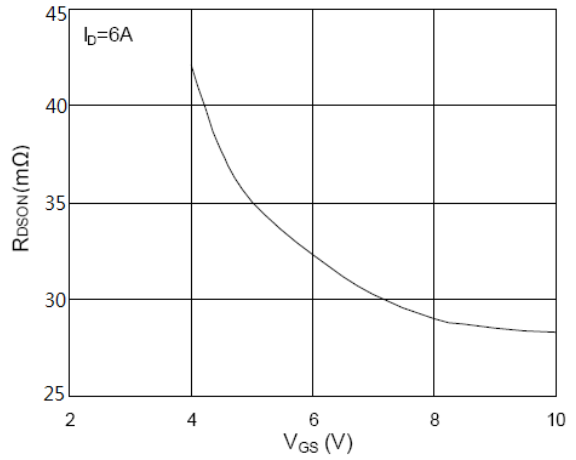


Fig.2 On-Resistance vs. G-S Voltage

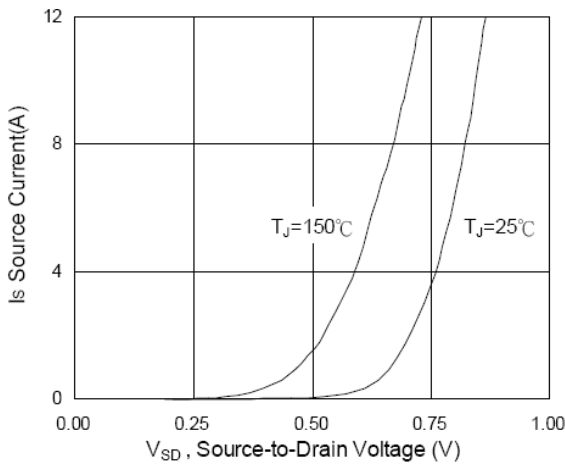


Fig.3 Forward Characteristics of Reverse

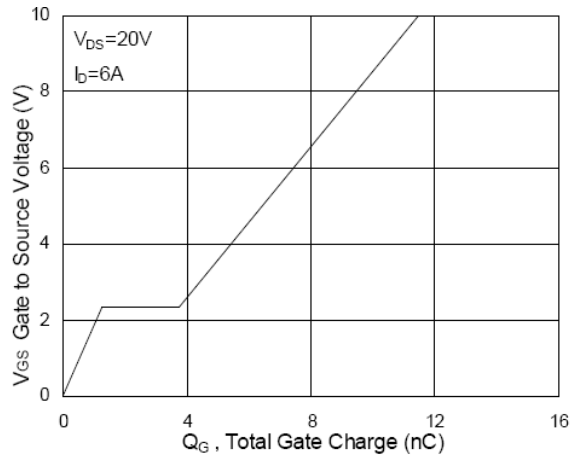


Fig.4 Gate-Charge Characteristics

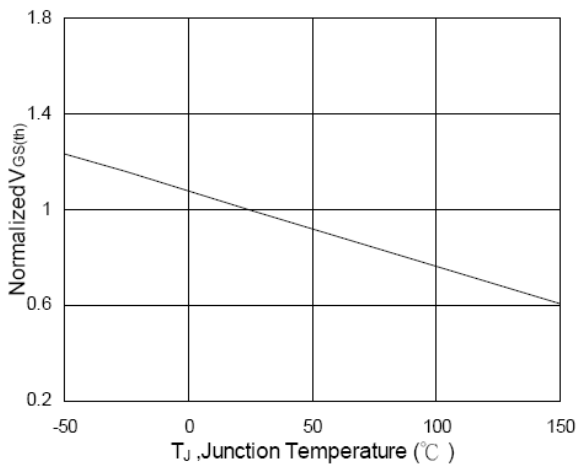


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

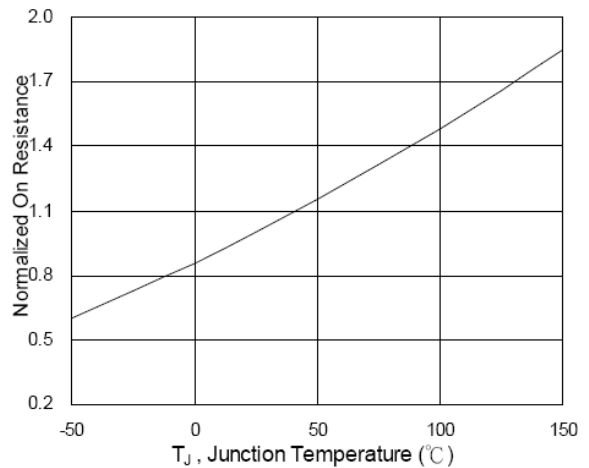


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

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CHARACTERISTICS CURVE

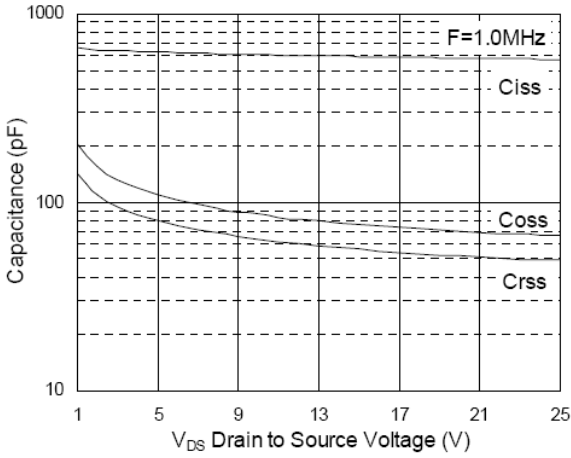


Fig.7 Capacitance

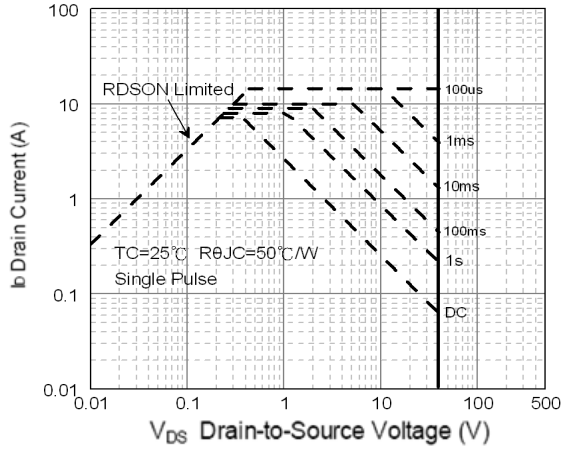


Fig.8 Safe Operating Area

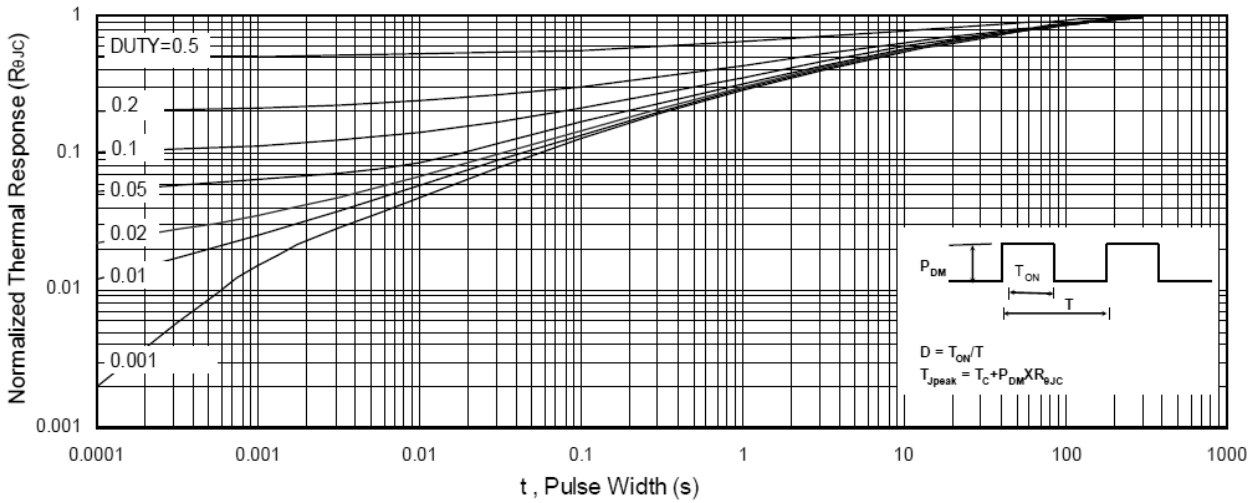


Fig.9 Normalized Maximum Transient Thermal Impedance

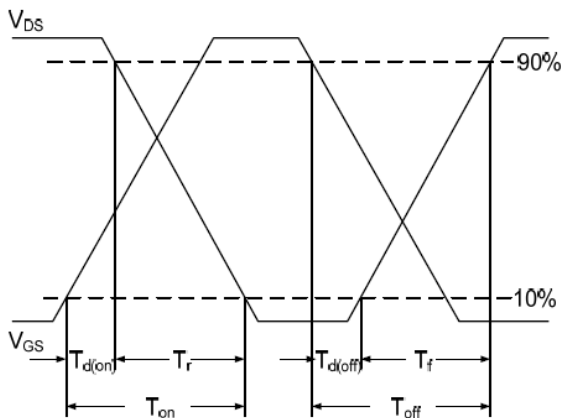


Fig.10 Switching Time Waveform

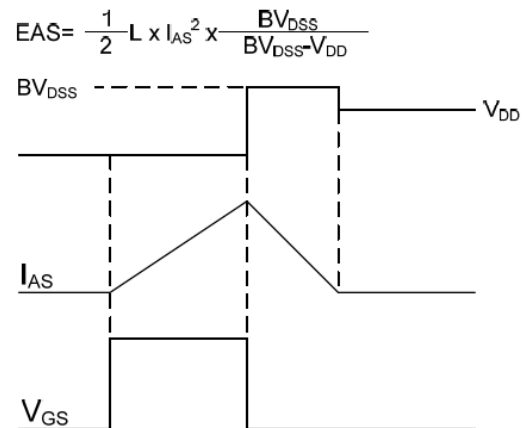


Fig.11 Unclamped Inductive Switching Wave